


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/840,192		FUJIKAWA ET AL.	
	Examiner		Art Unit	
	EDMUND H. LEE		1791	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
264		220			264	259	255	319	293		
INTERNATIONAL CLASSIFICATION											
B	2	9	C	59/02							
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(Assistant Examiner) (Date)					/EDMUND H. LEE/ PRIMARY EXAMINER, 1791 3/30/09					Total Claims Allowed: 14	
(Legal Instruments Examiner) (Date)					(Primary Examiner) (Date)					O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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